















Exams for group M19-483

Mon, 16 Dec	14:30 — 16:05	TEST	Technical English  Kudinova N.L.  323
Tue, 24 Dec	16:15 — 17:50	ATT	Sensors and gauges in microelectronics  Podlepetskiy B.I.  D-311
Wed, 25 Dec	16:15 — 17:50	ATT	Physics of electronic devices  Kondratenko S.V., Kessarinskiy L.N.  D-405
Wed, 25 Dec	18:00 — 20:00	TEST	Academic practice (technology)  Bocharov Y.I.  dep.27
Thu, 26 Dec	08:30 — 10:05	TEST	Physics of Semiconductors  Elesin V.V., Sogoyan A.V.  D-303
Wed, 15 Jan	09:00 — 13:00	EXAM	Sensors and gauges in microelectronics  Podlepetskiy B.I.  D-311
Mon, 20 Jan	09:00 — 13:00	EXAM	Physics of electronic devices  Kessarinskiy L.N., Kondratenko S.V.  D-405